

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/689,755	<b>Applicant(s)/Patent under Reexamination</b> SAEKI, KAZUHITO
	<b>Examiner</b> Alex Liew	<b>Art Unit</b> 2624

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner